

Search Notes

Application/Control No.

10/750,894

Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

HAN ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	Updated search	12/2/2006	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR